# **MOSFET** - N-Channel Silicon Carbide

650 V, 43.5 mΩ, 74 A

# Product Preview NTBG045N065SC1

#### MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V <sub>DSS</sub>	650	V	
Gate-to-Source Voltage	V <sub>GS</sub>	+18/-8	V	
Continuous Drain Current $R_{\theta JC}$			73.7	А
Power Dissipation $R_{\theta JC}$	T <sub>C</sub> = 25°C	P <sub>DC</sub>	425	W
Continuous Drain Current $R_{\theta JC}$	T 10000	I <sub>DC</sub>	57.2	А
Power Dissipation $R_{\theta JC}$	T <sub>C</sub> = 100°C	P <sub>DC</sub>	212	W
Continuous Drain Current $R_{\theta JA}$	т огоо	I <sub>DA</sub>	TBD	А
Power Dissipation $R_{\theta JA}$	T <sub>A</sub> = 25°C	P <sub>DA</sub>	TBD	W
Continuous Drain Current $R_{\theta JA}$			TBD	А
Power Dissipation $R_{\theta JA}$	T <sub>A</sub> = 100°C	P <sub>DA</sub>	TBD	W
Pulsed Drain Current $R_{\theta JC}$	I <sub>DM</sub>	315	А	
Operating Junction and Storage Te Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C	
Source Current (Body Diode)	I <sub>S</sub>	95.4	А	
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>GS</sub> = 18 V, I <sub>L(pk)</sub> = 1 A, L = 0.1 mH, R <sub>G</sub> = 25 $\Omega$ )		E <sub>AS</sub>	TBD	mJ
Lead Temperature for Soldering Purposes		ΤL	TBD	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE

Parameter	Symbol	Value	Unit
Junction-to-Case (Note 1)	$R_{\theta JC}$	0.353	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	TBD	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

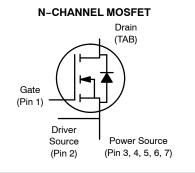
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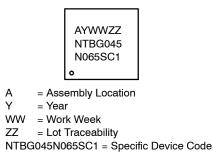
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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
650 V	43.5 m $\Omega$ @ VGS = 18 V	74 A





#### MARKING DIAGRAM



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS**

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \ I_{D} = 2.50 e - 04 A, \\ T_{C} = 25^\circ C \end{array}$	650			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 2.50e – 04A, T <sub>Jmax</sub> = 175°C		0.215		V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS}$ = 650 V, $T_{C}$ = 25°C			100	μA
		V <sub>DS</sub> = 650 V, T <sub>C</sub> = 175°C			1	mA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS}$ = +18/-8 V, $V_{DS}$ = 0 V			±1	μA
ON CHARACTERISTICS	•		•	•	•	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{G}$ = 18 V, I <sub>D</sub> = 20 A, T <sub>C</sub> = 25°C		43.48		mΩ
		$V_{G}$ = 18 V, $I_{D}$ = 20 A, $T_{C}$ = 175°C		52.4		
Gate Threshold Voltage	V <sub>GS(th)</sub>			3.19		V
Gate Threshold Voltage Temperature Coefficient	V <sub>GS(th)</sub> /T <sub>J</sub>	$V_{G} = V_{D}, I_{D} = 5.41e - 03A$		-6.42		mV/°C
Forward Transconductance	9 <sub>FS</sub>	V <sub>D</sub> = 10 V, I <sub>D</sub> = 20 A		10.81		S
CHARGES, CAPACITANCES & GATE	RESISTANCE		1	1		
Gate Resistance	R <sub>G</sub>			4.94		Ω
Input Capacitance	C <sub>ISS</sub>			1803		pF
Output Capacitance	C <sub>OSS</sub>	$V_D = 325 V$ , $V_G = 0 V$ , f = 1e6		156		
Reverse Transfer Capacitance	C <sub>RSS</sub>			13.78		-
Effective Output Capacitance	C <sub>OSSef</sub>			302		
Energy Related Output Capacitance	C <sub>OSSer</sub>	V <sub>DS</sub> = 0 to 325 V, V <sub>G</sub> = 0 V, f = 1e6		205		
Coss Stored Energy	E <sub>OSS</sub>			10.87		μJ
Total Gate Charge	Q <sub>G(tot)</sub>			85.1		nC
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>D</sub> = 520 V, I <sub>D</sub> = 20 A, V <sub>G</sub> = -5/18 V		26.11		
Gate-to-Drain Charge	Q <sub>GD</sub>	VG = -5/10 V		27.04		
SWITCHING CHARACTERISTICS				1		
Turn-On Delay Time	t <sub>d(on)</sub>			26.29		ns
Turn-Off Delay Time	t <sub>d(off)</sub>			38.49		
Rise Time	t <sub>r</sub>			8.15		
Fall Time	t <sub>f</sub>	$V_{GS}$ = -5/18 V, $V_{D}$ = 520 V, I <sub>D</sub> = 20 A, R <sub>G</sub> = 6 $\Omega$		10.03		
Turn-On Switching Loss	E <sub>ON</sub>	1 <u>0</u> = 207, 11 <u>0</u> = 0 11		0.179		mJ
Turn-Off Switching Loss	E <sub>OFF</sub>			0.035		
Total Switching Loss	E <sub>TOT</sub>			0.214		
SOURCE-TO-DRAIN DIODE CHARAG	TERISTICS		•	•		
Forward Diode Voltage	rd Diode Voltage $V_{SD}$ $V_{GS}$ = -5 V, I <sub>D</sub> = 2			4.29		V
		$V_{GS}$ = -5 V, I <sub>D</sub> = 20 A, T <sub>C</sub> = 175°C		3.76		1
Reverse Recovery Time	t <sub>RR</sub>			32.33		ns
Reverse Recovery Charge	Q <sub>RR</sub>	V <sub>GS</sub> = -5 V. I <sub>S</sub> = 20 A.		177		А
Reverse Recovery Energy	E <sub>REC</sub>	$V_{GS}$ = -5 V, I <sub>S</sub> = 20 A, dI/dt = 1000 A/µs, V <sub>DS</sub> = 520 V		19.14		1
Peak Reverse Recovery Current	I <sub>BBM</sub>			9.56		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

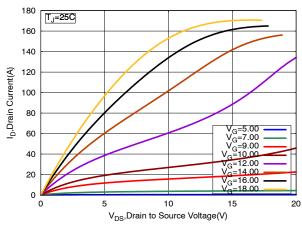
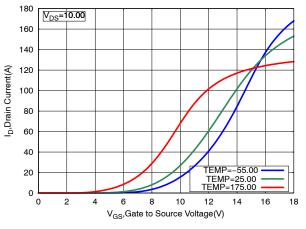
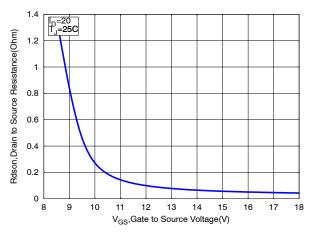
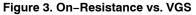


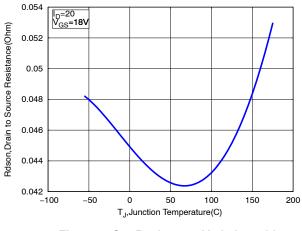
Figure 1. On-Region Characteristics













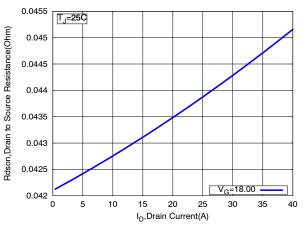


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

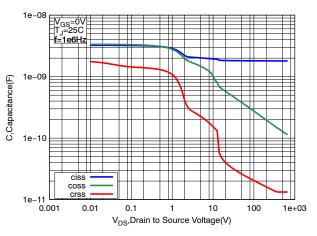
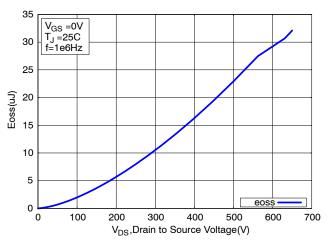


Figure 6. Capacitance Variation

#### **TYPICAL CHARACTERISTICS**





1e-06

1e-07

1e-08

1e-09

t,TIME(S)

V<sub>GS</sub> =18.00

V<sub>DS</sub> =520

I<sub>D</sub> =20.00

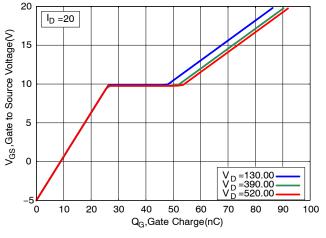


Figure 8. Gate-to-Source Voltage vs. Total Charge

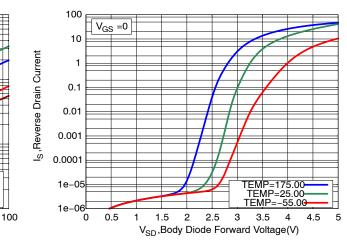


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

10

R<sub>G</sub>,Gate Resistance(Ohm)

tdon tdoff

tr Ħ

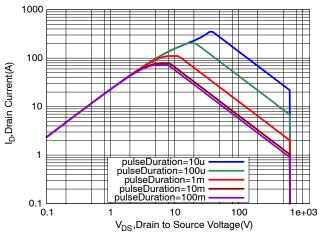


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 10. Diode Forward Voltage vs. Current

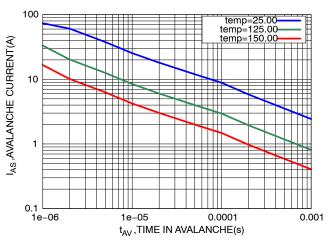


Figure 12. Ipeak vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

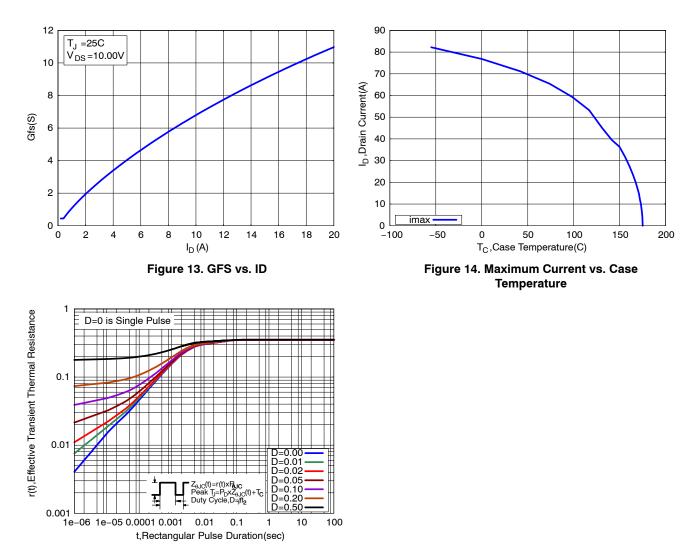


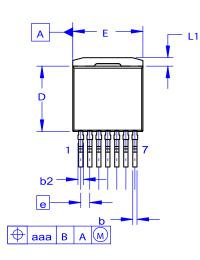
Figure 15. Thermal Response

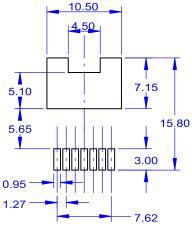
#### PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
NTBG045N065SC1	NTBG045N065SC1	D2PAK	Tape & Reel	TBD	TBD	800 Units

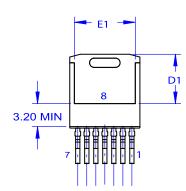
#### PACKAGE DIMENSIONS

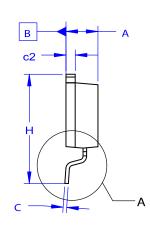
D<sup>2</sup>PAK7 (TO-263-7L HV) CASE 418BJ ISSUE A





LAND PATTERN RECOMMENDATION



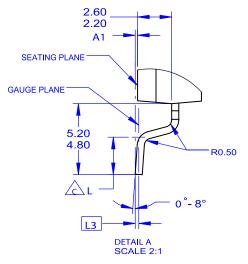


NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.
 D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
 E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	4.30	4.50	4.70	
A1	0.00	0.10	0.20	
b2	0.60	0.70	0.80	
b	0.51	0.60	0.70	
с	0.40	0.50	0.60	
c2	1.20	1.30	1.40	
D	9.00	9.20	9.40	
D1	6.75	6.95	7.15	
E	9.70	9.90	10.20	
E1	7.70	7.90	8.10	
е	~	1.27	~	
Н	15.10	15.40	15.70	
L	2.44	2.64	2.84	
L1	1.00	1.20	1.40	
L3	~	0.25	~	
aaa	~	~	0.25	



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